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NUV-VIS-NIR Nd:YAG Dual Camera Laser Line Vertical Mitutoyo Video Microscope Unit

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 ₹10,36,866

Price inclusive of all taxes

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Note: This item requires accessories for use | [Learn More](#)

Product Downloads

General	
378-513	Model Number:
NUV-VIS-NIR	Range:
Vertical Mount, Brightfield, Erect Image	Type:
	Manufacturer:

Mitutoyo	
Compatible Objectives: MPlan Apo/HR/SL, MPlan NIR/NUV, and MPlan UV	
Note: Note: Magnification: 1X Tube Lens	
Physical & Mechanical Properties	
Weight (g): 2000	
Optical Properties	
Design Wavelength DWL (nm): 355, 523, 1064nm	
Magnification: 1X	
Sensor	
Maximum Sensor Format: 2/3"	
Threading & Mounting	
Mount: C-Mount	
Mounting Threads: Objective Mounts: M26 x 36 TPI	
Regulatory Compliance	
RoHS 2015: Exempt	
Certificate of Conformance: View	
REACH 241: Contains SVHC(s)	
Country of Origin: Japan	
Imported By: Edmund Optics India Private Limited	

Product Details

- Designed for use with [Mitutoyo NIR, NUV, and UV Infinity Corrected Objectives](#)
- Maximum Sensor Size up to 2/3"
- Ideal for Laser Processing and Machining applications

Mitutoyo Nd:YAG Laser Line Video Microscope Units (VMU) allow for quick and easy setup of laser processing systems by connecting an infinity corrected objective to a c-mount camera. Optimized for Nd:YAG laser lines of 266, 355, 532, and 1064nm, these VMUs are designed for use with [Mitutoyo UV, NUV, and NIR infinity corrected objectives](#). These VMUs can also be used as infrared inspection systems when using an infrared light source and an infrared camera. Mitutoyo Nd:YAG Laser Line Video Microscope Units (VMU) are ideal for laser processing and imaging applications such as cutting, trimming, and repair of IC wiring, thin-film processing, and infrared spectral characteristic analysis. A dual-camera laser line VMU option is also available for high and low magnification observation.